

Field Effect Transistor

Silicon N Channel MOS Type (π -MOS III.5)

High Speed, High Current DC-DC Converter,

Relay Drive and Motor Drive Applications

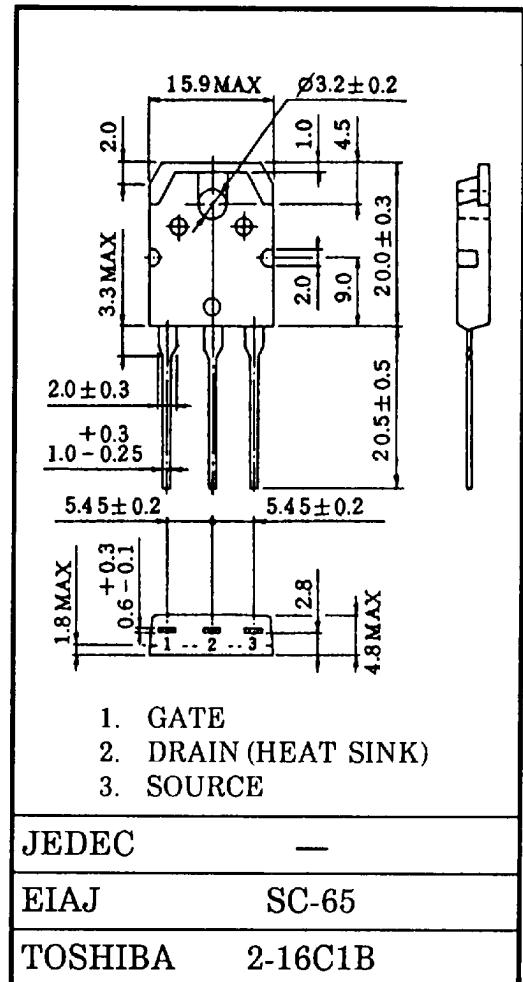
Features

- Low Drain-Source ON Resistance
 - $R_{DS(ON)} = 0.75\Omega$ (Typ.)
- High Forward Transfer Admittance
 - $|Y_{fs}| = 4.9S$ (Typ.)
- Low Leakage Current
 - $I_{DSS} = 300\mu A$ (Max.) @ $V_{DS} = 500V$
- Enhancement-Mode
 - $V_{th} = 2.0 \sim 4.0V$ @ $V_{DS} = 10V, I_D = 1mA$

Absolute Maximum Ratings ($T_a = 25^\circ C$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	V_{DSS}	500	V
Drain-Gate Voltage ($R_{GS} = 20k\Omega$)	V_{DGR}	500	V
Gate-Source Voltage	V_{GSS}	± 30	V
Drain Current	DC	I_D	10
	Pulse	I_{DP}	40
Drain Power Dissipation ($T_c = 25^\circ C$)	P_D	125	W
Channel Temperature	T_{ch}	150	$^\circ C$
Storage Temperature Range	T_{stg}	-55 ~ 150	$^\circ C$

Unit in mm



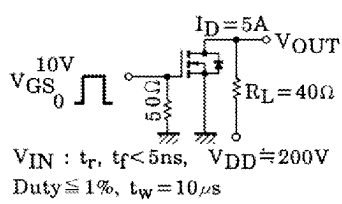
Weight : 4.6g

Thermal Characteristics

CHARACTERISTIC	SYMBOL	MAX.	UNIT
Thermal Resistance, Channel to Case	$R_{th(ch-c)}$	1.0	$^\circ C/W$
Thermal Resistance, Channel to Ambient	$R_{th(ch-a)}$	50	$^\circ C/W$

This transistor is an electrostatic sensitive device.
Please handle with care.

Electrical Characteristics (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate Leakage Current		I_{GSS}	$V_{GS} = \pm 30V, V_{DS} = 0V$	–	–	± 100	nA
Drain Cut-off Current		I_{DSS}	$V_{DS} = 500V, V_{GS} = 0V$	–	–	300	μA
Drain-Source Breakdown Voltage		$V_{(BR)DSS}$	$I_D = 10mA, V_{GS} = 0V$	500	–	–	V
Gate Threshold Voltage		V_{th}	$V_{DS} = 10V, I_D = 1mA$	2.0	–	4.0	V
Drain-Source ON Resistance		$R_{DS(ON)}$	$I_D = 5A, V_{GS} = 10V$	–	0.75	1.0	Ω
Forward Transfer Admittance		$ Y_{fs} $	$V_{DS} = 10V, I_D = 5A$	3.0	4.9	–	S
Input Capacitance		C_{iss}	$V_{DS} = 10V, V_{GS} = 0V,$ $f = 1MHz$	–	870	1100	pF
Reverse Transfer Capacitance		C_{rss}		–	75	250	
Output Capacitance		C_{oss}		–	210	300	
Switching Time	Rise Time	t_r	 <p>$I_D = 5A$ $V_{GS} = 10V$ $R_L = 40\Omega$ $V_{IN} : t_r, t_f < 5ns, V_{DD} = 200V$ Duty $\leq 1\%$, $t_w = 10\mu s$</p>	–	30	90	ns
	Turn-on Time	t_{on}		–	60	140	
	Fall Time	t_f		–	35	130	
	Turn-off Time	t_{off}		–	100	300	
Total Gate Charge (Gate-Source Plus Gate-Drain)		Q_g	$V_{DD} = 400V, V_{GS} = 10V,$ $I_D = 10A$	–	40	85	nC
Gate-Source Charge		Q_{gs}		–	16	–	
Gate-Drain ("Miller") Charge		Q_{gd}		–	24	–	

Source-Drain Diode Ratings and Characteristics (Ta = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Continuous Drain Reverse Current	I_{DR}	–	–	–	10	A
Pulse Drain Reverse Current	I_{DRP}	–	–	–	40	A
Diode Forward Voltage	V_{DSF}	$I_{DR} = 10A, V_{GS} = 0V$	–	–	-2.0	V
Reverse Recovery Time	t_{rr}	$I_{DR} = 10A, V_{GS} = 0V$	–	360	–	ns
Reverse Recovered Charge	Q_{rr}	$dI_{DR}/dt = 100A/\mu s$	–	3.0	–	μC

